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Ap	plicati	ion/Control	No.

Applicant(s)/Patent under Reexamination

09/922,076

Examiner

KAGEYAMA ET AL.

Minh Dieu Nguyen

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SEARCHED			
Class	Subclass	Date	Examiner
380	201	12/26/2006	MDN
705	57, 59	12/26/2006	MDN
360	60	12/26/2006	MDN
369	84-85	12/26/2006	MDN
715	741	12/26/2006	MDN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT, IBM-TDB)	12/26/2006	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT, IBM-TDB)	12/26/2006	MDN
Every claim has been reviewed for 35 USC non-statutory subject matter	12/26/2006	MDN
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